CRYSTAL AND MOLECULAR STRUCTURE OF 2,5,5-TRIMETHYL-2-THIONO-1,3,2-DIOXAPHOSPHORINANE

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In connection with investigations directed toward the study of the thermodynamical stability of $1,3,2$-dioxaphosphorinanes ${ }^{1}$, we have been interested in the nmr and stereochemistry of the 2-thiono-1,3,2-dioxaphosphorinanes 2 .

Although several unsubstituted or 5,5-disubstituted 2-oxo-1,3,2-dioxaphosphorinanes have been studied by X-ray diffraction technique ${ }^{3}$, there has been no $X$-ray studies concerning the 2-thiono-1,3,2-dioxaphosphorinanes. We wish to report here the X-ray structure determination of the $2,5,5$-trimethyl-2-thiono-1,3,2-dioxaphosphorinane.


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2,5,5 \text {-Trimethyl-2-thiono-1,3,2-dioxaphosphorinane }
$$

The $2,5,5$-trimethyl-2-thiono-1,3,2-dioxaphosphorinane was readily synthesized by reacting methylphosphonothioic dichloride (Ethyl Corporation) and 2,2-dimethyl-1,3-propanediol (Aldrich). The crystals used in this investigation were recrystallized from warm cyclohexane. Due to slight decomposition under X-ray irradiation, the crystal was sealed in thin-walled capillary tube for data collection.

The crystals are orthorhombic, space group $P_{2,2,2}$ (hoo, oko and ool absent for $h, k$ or 1 odd). Other crystal data are summarized in Table 1.

TABLE I
2,5,5-Trimethyl-2-thiono-1,3,2-dioxaphosphorinane $\mathrm{C}_{6} \mathrm{H}_{13} \mathrm{O}_{2} \mathrm{PS}$ orthorhombic space group

| F.W. | $=180.21$ | $a=10.969 \pm 0.001$ |
| :---: | :---: | :---: |
| $\mathrm{F}(000)$ | $=96$ | $b=14.656 \pm 0.001$ |
| $P_{21212}$ |  | $c=5.797 \pm 0.001$ |
| $\mathrm{D}_{\mathrm{m}}$ | $=1.23(5)$ | $V=931.936 \mathrm{~A}^{3}$ |
| $D_{x}$ | $=1.285$ | $z=4$ |

The crystal used for measuring intensities was mounted about the $c$ axis. The intensities of 1071 independent reflections $\left(3^{\circ}<\theta<70^{\circ}\right)$ were recorded using Ni-filtered Cuk $\alpha$ radiation on a four circle Siemens diffractometer. The $2 \overline{9} 1$ reflection was checked periodically. It showed no drop-off in intensity during the data collection experiment. The structure was solved by direct methods with the program MULTAN ${ }^{4}$. Least-squares refinment, using the ORFLS program 5 ( $\mathrm{P}, \mathrm{O}, \mathrm{C}, \mathrm{S}$ anisotropic) has reached an $R$ index ( $R=\sum\left|F_{0}-F_{c}\right| / \sum\left|F_{0}\right|$ ) of 0.06 for 992 reflections.

Tables II and III give the bond distances and the bond angles with their standard deviations.

TABLE II

| Bond distances ( A ) |  | Standard deviations (X. $10^{3}$ ) are given in parenthese |  |
| :--- | :--- | :--- | :--- | :--- |
| $\mathrm{P}-\mathrm{O}_{1}$ | $1.586(4)$ | $0_{1}-\mathrm{C}_{6}$ | $1.468(7)$ |
| $\mathrm{P}-\mathrm{O}_{3}$ | $1.582(4)$ | $\mathrm{O}_{3}-\mathrm{C}_{4}$ | $1.472(7)$ |
| $\mathrm{P}-\mathrm{S}$ | $1.933(2)$ | $\mathrm{C}_{4}-\mathrm{C}_{5}$ | $1.530(8)$ |
| $\mathrm{P}-\mathrm{C}_{7}$ | $1.772(7)$ | $\mathrm{C}_{5}-\mathrm{C}_{6}$ | $1.537(8)$ |
| $\mathrm{C}_{5}-\mathrm{C}_{8}$ | $1.536(8)$ | $\mathrm{C}_{5}-\mathrm{C}_{9}$ | $1.549(7)$ |

TABLE III

| Bond angles $\left({ }^{\circ}\right)$ | Standard deviations are given in parenthese |  |  |
| :--- | :--- | :--- | :--- |
| $\mathrm{O}_{1}-\mathrm{P}-\mathrm{S}$ | $115.1(0.2)$ | $\mathrm{O}_{1}-\mathrm{C}_{6}-\mathrm{C}_{5}$ | $111.1(0.4)$ |
| $\mathrm{O}_{3}-\mathrm{P}-\mathrm{S}$ | $114.0(0.2)$ | $\mathrm{O}_{3}-\mathrm{C}_{4}-\mathrm{C}_{5}$ | $110.8(0.5)$ |
| $\mathrm{O}_{1}-\mathrm{P}-\mathrm{C}_{7}$ | $102.7(0.3)$ | $\mathrm{C}_{4}-\mathrm{C}_{5}-\mathrm{C}_{6}$ | $108.7(0.4)$ |
| $\mathrm{O}_{3}-\mathrm{P}-\mathrm{C}_{7}$ | $103.2(0.3)$ | $\mathrm{C}_{4}-\mathrm{C}_{5}-\mathrm{C}_{8}$ | $107.3(0.5)$ |
| $\mathrm{S}-\mathrm{P}-\mathrm{C}_{7}$ | $116.7(0.3)$ | $\mathrm{C}_{6}-\mathrm{C}_{5}-\mathrm{C}_{8}$ | $108.1(0.5)$ |
| $\mathrm{O}_{1}-\mathrm{P}-\mathrm{O}_{3}$ | $103.5(0.2)$ | $\mathrm{C}_{6}-\mathrm{C}_{5}-\mathrm{C}_{9}$ | $109.3(0.5)$ |
| $\mathrm{P}-\mathrm{O}_{1}-\mathrm{C}_{6}$ | $115.5(0.4)$ | $\mathrm{C}_{4}-\mathrm{C}_{5}-\mathrm{C}_{9}$ | $111.2(0.5)$ |
| $\mathrm{P}-\mathrm{O}_{3}-\mathrm{C}_{4}$ | $115.9(0.3)$ | $\mathrm{C}_{8}-\mathrm{C}_{5}-\mathrm{C}_{9}$ | $112.2(0.5)$ |

The ring adopts a chair conformation (figure). The $\mathrm{P}=\mathrm{S}$ bond points in the axial direction and the methyl group is in equatorial position. It must be pointed out that in all the 2-oxo-dioxaphosphorinanes reported in reference (3), the $P=0$ bond is equatorial. Least-squares planes calculation shows that atoms $P, S, C(7), C(5), C(8)$ and $C(9)$ are almost planar (deviations : $0.003,-0.007,0.005,-0.002$ and $0.003 \AA$ respectively). Atoms $O(1), O(3), C(4)$ and $C(6)$ are $1.242,-1.251,1.244$ and $-1.244 \AA$ away from this plane. The dihedral angle between the plane formed by $P, O(1), O(3)$ and the least-squares planes through the atoms $O(1), O(3), C(4)$ and $C(6)$ is $45^{\circ} 7$, while that formed between the $C(4), C(5), C(6)$ plane and the least-squares plane is $51^{\circ} 9$. Thus, the flattening out of this 2-thiono-1,3,2-dioxaphosphorinane is smaller than the one found in the 2-oxo-1,3,2-dioxaphosphorinane rings ${ }^{3}$.

The $\mathrm{P}=\mathrm{S}$ bond distances measured by X-ray diffraction and which range from 1.98 A to $1.85 \AA 6,7$ may differ significantly from the $P=S$ value reported here $(1.933 \mathrm{~A})$. The other bond lengths agree with those found in 2-oxo-1,3,2-dioxaphosphorinanes. There are no intermolecular contacts short enough to affect the conformation of the ring.

The X -ray structure determination of other 2-R-2-thiono-1,3,2-dioxaphosphorinanes ( $\mathrm{R}=\mathrm{C}, \mathrm{O}_{6} \mathrm{C}_{5}$ ) which are predicted as having an equatorial $\mathrm{P}=\mathrm{S}$ bond orientation in a low electric permeability medium is now under way.


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